September 2015



FNB50560TD1 Motion SPM[®] 55 Series

Features

- UL Certified No. E209204 (UL1557)
- 600 V 5 A 3-Phase IGBT Inverter Including Control IC for Gate Drive and Protections
- Low-Loss, Short-Circuit Rated IGBTs
- Built-In Bootstrap Diodes in HVIC
- Separate Open-Emitter Pins from Low-Side IGBTs for Three-Phase Current Sensing
- Active-HIGH interface, works with 3.3 / 5 V Logic, Schmitt-trigger Input
- HVIC for Gate Driving, Under-Voltage and Short-Circuit Current Protection
- Fault Output for Under-Voltage and Short-Circuit Current Protection
- Inter-Lock Function to Prevent Short-Circuit
- Shut-Down Input
- HVIC Temperature-Sensing Built-In for Temperature Monitoring
- Optimized for 15 20 kHz Switching Frequency
- Isolation Rating: 1500 V_{rms} / min.

Applications

• Motion Control - Home Appliance / Industrial Motor

Related Resources

- <u>AN-9096 Smart Power Module, Motion SPM® 55</u> <u>Series User's Guide</u>
- AN-9097 SPM® 55 Packing Mounting Guidance



General Description

variety of control algorithms.

FNB50560TD1 is a Motion SPM 55 module providing a fully-featured, high-performance inverter output stage for

AC Induction, BLDC, and PMSM motors. These modules

integrate optimized gate drive of the built-in IGBTs to

minimize EMI and losses, while also providing multiple

on-module protection features including under-voltage lockouts, inter-lock function, over-current shutdown,

thermal monitoring of drive IC, and fault reporting. The built-in, high-speed HVIC requires only a single supply

voltage and translates the incoming logic-level gate

inputs to the high-voltage, high-current drive signals

required to properly drive the module's robust short-

are available for each phase to support the widest

circuit-rated IGBTs. Separate negative IGBT terminals

Figure 1. 3D Package Drawing (Click to Activate 3D Content)

Package Marking and Ordering Information

| Device | Device Marking | Package | Packing Type | Quantity |
|-------------|----------------|-----------|--------------|----------|
| FNB50560TD1 | FNB50560TD1 | SPMFA-A20 | RAIL | 13 |

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Integrated Power Functions

• 600 V - 5 A IGBT inverter for three phase DC / AC power conversion (Please refer to Figure 3)

Integrated Drive, Protection and System Control Functions

- For inverter high-side IGBTs: gate drive circuit, high-voltage isolated high-speed level shifting
 control circuit Under-Voltage Lock-Out (UVLO) protection
- Fault signaling: corresponding to UVLO (low-side supply) and SC faults
- Input interface: High-active interface, works with 3.3 / 5 V logic, Schmitt trigger input
- Built in Bootstrap circuitry in HVIC

Pin Configuration

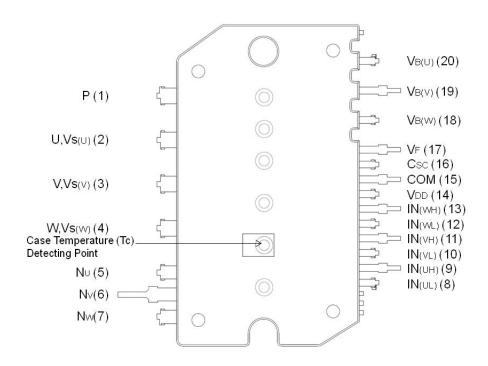


Figure 2. Top View

| Pin Number | Pin Name | Pin Description |
|------------|-----------------------|---|
| 1 | Р | Positive DC-Link Input |
| 2 | U, V _S (U) | Output for U Phase |
| 3 | V, V _S (V) | Output for V Phase |
| 4 | W, V _S (W) | Output for W Phase |
| 5 | NU | Negative DC-Link Input for U Phase |
| 6 | N _V | Negative DC-Link Input for V Phase |
| 7 | N _W | Negative DC-Link Input for W Phase |
| 8 | IN _(UL) | Signal Input for Low-Side U Phase |
| 9 | IN _(UH) | Signal Input for High- ide U Phase |
| 10 | IN _(VL) | Signal Input for Low-Side V Phase |
| 11 | IN _(VH) | Signal Input for High-Side V Phase |
| 12 | IN _(WL) | Signal Input for Low-Side W Phase |
| 13 | IN _(WH) | Signal Input for High-Side W Phase |
| 14 | V _{DD} | Common Bias Voltage for IC and IGBTs Driving |
| 15 | СОМ | Common Supply Ground |
| 16 | C _{SC} | Capacitor (Low-Pass Filter) for Short-circuit Current Detection Input |
| 17 | V _F | Fault Output, Shut-Down Input, Temperature Output of Drive IC |
| 18 | V _{B(W)} | High-Side Bias Voltage for W-Phase IGBT Driving |
| 19 | V _{B(V)} | High-Side Bias Voltage for V-Phase IGBT Driving |
| 20 | V _{B(U)} | High-Side Bias Voltage for U-Phase IGBT Driving |

Internal Equivalent Circuit and Input/Output Pins Ρ V_{B(U)} VB HO IN(UH) HIN IN(UL) LIN U,Vs(U) VS LO Nu V_{B(V)} VВ но HIN IN(VL) V,Vs(V) LIN vs LO Νv V_{B(W)} VB IN(WH) HIN 🛓

LIN

V_F Csc

VDD

СОМ

но

vs

LO

Figure 3. Internal Block Diagram

U,Vs(W)

Nw

Note:

1. Inverter high-side is composed of three IGBTs, freewheeling diodes, and one control IC for each IGBT.

(IN(WL)

VF

COM

- 2. Inverter low-side is composed of three IGBTs, freewheeling diodes, and one control IC for each IGBT. It has gate drive and protection functions.
- 3. Single drive IC has gate driver for six IGBTs and protection functions.
- 4. Inverter power side is composed of four inverter DC-link input terminals and three inverter output terminals.

Absolute Maximum Ratings (T_J = 25°C, unless otherwise specified.)

Inverter Part

| Symbol | Parameter | Conditions | Rating | Unit |
|------------------------|------------------------------------|--|-----------|------|
| V _{PN} | Supply Voltage | Applied between P - N _U , N _V , N _W | 450 | V |
| V _{PN(Surge)} | Supply Voltage (Surge) | Applied between P - N _U , N _V , N _W | 500 | V |
| V _{CES} | Collector - Emitter Voltage | | 600 | V |
| * ± I _C | Each IGBT Collector Current | $T_{C} = 25^{\circ}C, T_{J} < 150^{\circ}C$ | 5 | А |
| * ± I _{CP} | Each IGBT Collector Current (Peak) | T_{C} = 25°C, $T_{J}<$ 150°C, Under 1 ms Pulse Width | 10 | A |
| * P _C | Collector Dissipation | T _C = 25°C per Chip | 19 | W |
| Τ _J | Operating Junction Temperature | (Note 5) | -40 ~ 150 | °C |

Note:

5. The maximum junction temperature rating of the power chips integrated within the Motion SPM[®] 55 product is 150°C.

Control Part

| Symbol | Parameter | Conditions | Rating | Unit |
|------------------|--------------------------------|---|-----------------------------|------|
| V _{DD} | Control Supply Voltage | Applied between V _{DD} - COM | 20 | V |
| V_{BS} | High-Side Control Bias Voltage | Applied between V_B(U) - V_S(U), V_B(V) - V_S(V), V_B(W) - V_S(W) | 20 | V |
| V _{IN} | Input Signal Voltage | $\begin{array}{llllllllllllllllllllllllllllllllllll$ | -0.3 ~ V _{DD} +0.3 | V |
| V _F | Fault Supply Voltage | Applied between V _F - COM | -0.3 ~ V _{DD} +0.3 | V |
| * I _F | Fault Current | Sink Current at V _F pin | 5 | mA |
| V _{SC} | Current Sensing Input Voltage | Applied between C _{SC} - COM | -0.3 ~ V _{DD} +0.3 | V |

Total System

| Symbol | Parameter | Conditions | Rating | Unit |
|-----------------------|---|--|-----------|------------------|
| V _{PN(PROT)} | Self Protection Supply Voltage Limit (Short Circuit Protection Capability) | $V_{DD} = V_{BS} = 13.5 \sim 16.5 V$ T _J = 150°C, Non-Repetitive, < 2 µs | 400 | V |
| T _{STG} | Storage Temperature | | -40 ~ 125 | °C |
| V _{ISO} | Isolation Voltage Connect Pins to Heat Sink Plate | AC 60 Hz, Sinusoidal, 1 Minute | 1500 | V _{rms} |

Thermal Resistance

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-----------------------|-------------------------------------|---------------------------------------|------|------|------|--------|
| R _{th(j-c)Q} | Junction to Case Thermal Resistance | Inverter IGBT part (per 1 / 6 module) | - | - | 6.5 | °C / W |
| R _{th(j-c)F} | (Note 7) | Inverter FWD part (per 1 / 6 module) | - | - | 8.9 | °C / W |

Note:

6. For Marking " * ", These Value had been made an acquisition by the calculation considered to design factor.

7. For the measurement point of case temperature (T_C), please refer to Figure 2.

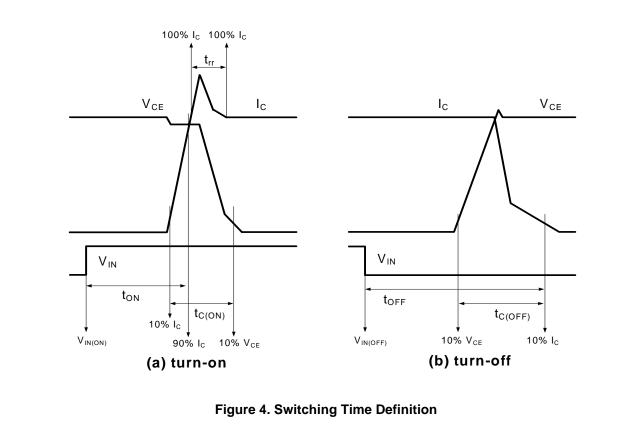
Electrical Characteristics (T_J = 25°C, unless otherwise specified.)

Inverter Part

| S | ymbol | Parameter | Cond | ditions | Min. | Тур. | Max. | Unit |
|----|---------------------|--|--|---|------|------|------|------|
| V | CE(SAT) | Collector - Emitter Saturation Voltage | $V_{IN} = 5 V$ | $V_{\rm IN} = 5 \rm V$ | - | 1.9 | 2.25 | V |
| | | | $I_{\rm C} = 4 {\rm A}$ | $T_J = 150^{\circ}C$ | - | 2.4 | - | V |
| | V _F | FWDi Forward Voltage | V _{IN} = 0 V | $T_J = 25^{\circ}C$ | - | 2.2 | 2.55 | V |
| | | | $I_F = 4 A$ | T _J = 150°C | - | 2.0 | - | V |
| HS | t _{ON} | Switching Times | $V_{PN} = 400 \text{ V}, V_{DD} = V$ | ν _{BS} = 15 V, I _C = 5Α | 0.30 | 0.60 | 0.90 | us |
| | t _{C(ON)} | | $T_J = 25^{\circ}C$ $V_{IN} = 0 V \leftrightarrow 5 V$, Indu | uctive load | - | 0.15 | 0.35 | us |
| | t _{OFF} | | (Note 8) $($ | | - | 0.30 | 0.50 | us |
| | t _{C(OFF)} | | | | - | 0.08 | 0.20 | us |
| | t _{rr} | | | | - | 0.08 | - | us |
| LS | t _{ON} | | $V_{PN} = 400 \text{ V}, V_{DD} = V$ | / _{BS} = 15 V, I _C = 5A | 0.30 | 0.60 | 0.90 | us |
| | t _{C(ON)} | | $T_J = 25^{\circ}C$ $V_{IN} = 0 V \leftrightarrow 5 V$, Indu | uctive load | - | 0.15 | 0.35 | us |
| | t _{OFF} | | (Note 8) $($ | | - | 0.30 | 0.50 | us |
| | t _{C(OFF)} | | | | - | 0.08 | 0.20 | us |
| | t _{rr} | | | | - | 0.08 | - | us |
| | I _{CES} | Collector - Emitter Leakage Current | $V_{CE} = V_{CES}$ | | - | - | 1 | mA |

Note:

 t_{ON} and t_{OFF} include the propagation delay of the internal drive IC. t_{C(ON)} and t_{C(OFF)} are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Figure 4.



| FNB50560TD1 |
|-----------------|
| Motion |
| SPM® 55 |
| 5 Series |

| Symbol | Parameter | Conditions | | Min. | Тур. | Max. | Unit |
|----------------------|---|---|--|------|------|------|------|
| I _{QDD} | Quiescent V _{DD} Supply Current | V _{DD} = 15 V, IN _(UH,VH,WH,UL,VL,WL) = 0 V | V _{DD} - COM | - | 1.5 | 2.0 | mA |
| I _{PDD} | Operating V _{DD} Supply Current | V _{DD} = 15 V, f _{PWM} = 20 kHz, duty = 50%, applied to one PWM signal input | V _{DD} - COM | - | 2.0 | 2.5 | mA |
| I _{QBS} | Quiescent V _{BS} Supply Current | $V_{BS} = 15 \text{ V}, \text{ IN}_{(UH, VH, WH)} = 0 \text{ V}$ | V _{B(U)} - V _{S(U)} , V _{B(V)} - V _{S(V)} , V _{B(W)} - V _{S(W)} | - | 30 | 60 | μΑ |
| I _{PBS} | Operating V _{BS} Supply Current | $V_{DD} = V_{BS} = 15$ V, $f_{PWM} = 20$ kHz, duty = 50%, applied to one PWM signal input for high - side | | - | 500 | 650 | μA |
| V_{FH} | Fault Output Voltage | V_{SC} = 0 V, V_F Circuit: 10 k Ω to 5 V | Pull-up | 4.5 | - | - | V |
| V _{FL} | | V_{SC} = 1 V, V_F Circuit: 10 k Ω to 5 V Pull-up | | - | - | 0.5 | V |
| V _{SC(ref)} | Short-Circuit Trip Level | V _{DD} = 15 V (Note 4) | | 0.45 | 0.5 | 0.55 | V |
| UV_DDD | | Detection level | | 10.7 | 11.4 | 12.1 | V |
| UV _{DDR} | Supply Circuit Under-Voltage | Reset level Detection level | | 11.2 | 12.3 | 13.0 | V |
| UV_BSD | Protection | | | 10.1 | 10.8 | 11.5 | V |
| UV_BSR | | Reset level | | 10.7 | 11.4 | 12.1 | V |
| I _{FT} | HVIC Temperature Sensing Current | $V_{DD} = V_{BS} = 15 \text{ V}, \text{ T}_{HVIC} = 25^{\circ}\text{C}$ | | 68 | 81 | 95 | μA |
| V_{FT} | HVIC Temperature Sensing Voltage | $V_{DD} = V_{BS} = 15 \text{ V}, \text{ T}_{\text{HVIC}} = 25^{\circ}\text{C}, 10$ (Figure. 5) |) k Ω to 5 V Pull-up | 4.05 | 4.19 | 4.32 | V |
| t _{FOD} | Fault-Out Pulse Width | | | 40 | 120 | - | μs |
| V _{FSDR} | Shut-down Reset level | Applied between V _F - COM | | - | - | 2.4 | V |
| V_{FSDS} | Shut-down Set level | | | 0.8 | - | - | V |
| V _{IN(ON)} | ON Threshold Voltage | Applied between IN(UH), IN(VH), II | N _(WH) , IN _(UL) , IN _(VL) , | - | - | 2.4 | V |
| V _{IN(OFF)} | OFF Threshold Voltage | IN _(WL) - COM | | 0.8 | - | - | V |

9. Short-circuit protection is functioning for all six IGBTs.

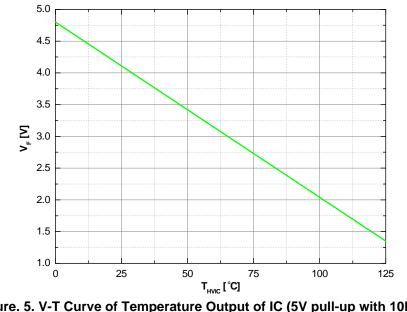


Figure. 5. V-T Curve of Temperature Output of IC (5V pull-up with 10kohm)

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| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-----------------|------------------------------|--|------|------|------|------|
| R _{BS} | Bootstrap Diode Resitance | V _{DD} = 15V, T _C = 25°C | - | 280 | - | Ω |
| | | 0.06 0.05 0.04 0.04 0.02 0.02 0.01 | | | | |

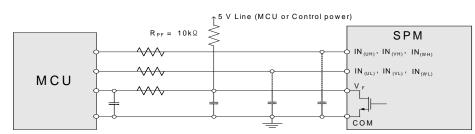


Recommended Operating Conditions

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|---|---|---|------|------|------|------|
| V _{PN} | Supply Voltage | Applied between P - N _U , N _V , N _W | - | 300 | 400 | V |
| V _{DD} | Control Supply Voltage | Applied between V _{DD} - COM | 14.0 | 15 | 16.5 | V |
| V _{BS} | High - Side Bias Voltage | Applied between V_B(U) - V_S(U), V_B(V) - V_S(V), V_B(W) - V_S(W) | 13.0 | 15 | 18.5 | V |
| dV _{DD} / dt, dV _{BS} / dt | Control Supply Variation | | -1 | - | 1 | V/μs |
| t _{dead} | Blanking Time for Preventing Arm - Short | For each input signal | 0.5 | - | - | μS |
| f _{PWM} | PWM Input Signal | $-40^{\circ}C < T_{J} < 150^{\circ}C$ | - | - | 20 | kHz |
| V _{SEN} | Voltage for Current Sensing | Applied between N _U , N _V , N _W - COM (Including surge voltage) | -4 | | 4 | V |
| P _{WIN(ON)} | Minimun Input Pulse | (Note 10) | 0.7 | - | - | μs |
| P _{WIN(OFF)} | Width | | 0.7 | - | - | |

Note:

10. This product might not make response if input pulse width is less than the recommanded value.



Note:

11. RC coupling at each input (parts shown dotted) might change depending on the PWM control scheme used in the application and the wiring impedance of the application's printed circuit board. The input signal section of the SPM 55 product integrates 10 kΩ (typ.) pull-down resistor. Therefore, when using an external filtering resistor, please pay attention to the signal voltage drop at input terminal.

Figure 7. Recommended MCU I/O Interface Circuit

| Parameter | Conditions | | Min. | Тур. | Max. | Unit |
|-----------------|----------------------|-------------------------|------|------|------|---------|
| Device Flatness | See Figure 8 | See Figure 8 | | | 100 | μm |
| Mounting Torque | Mounting Screw: - M3 | Recommended 0.7 N • m | 0.6 | 0.7 | 0.8 | N • m |
| | Note Figure 9 | Recommended 7.1 kg • cm | 5.9 | 6.9 | 7.9 | kg • cm |
| Weight | | • | - | 6.0 | - | g |

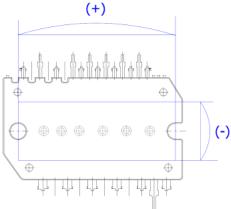
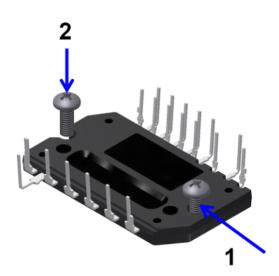
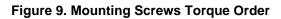


Figure 8. Flatness Measurement Position

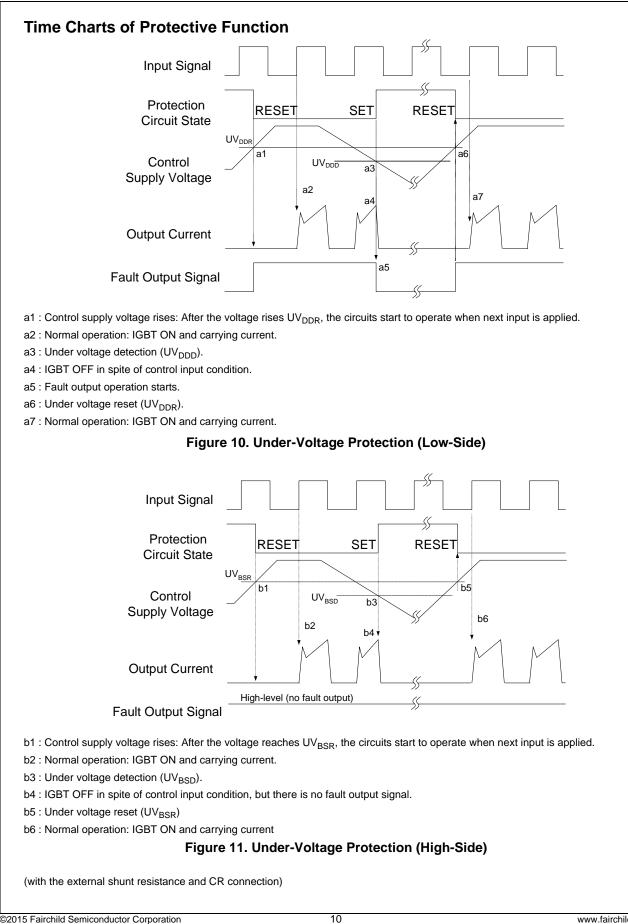


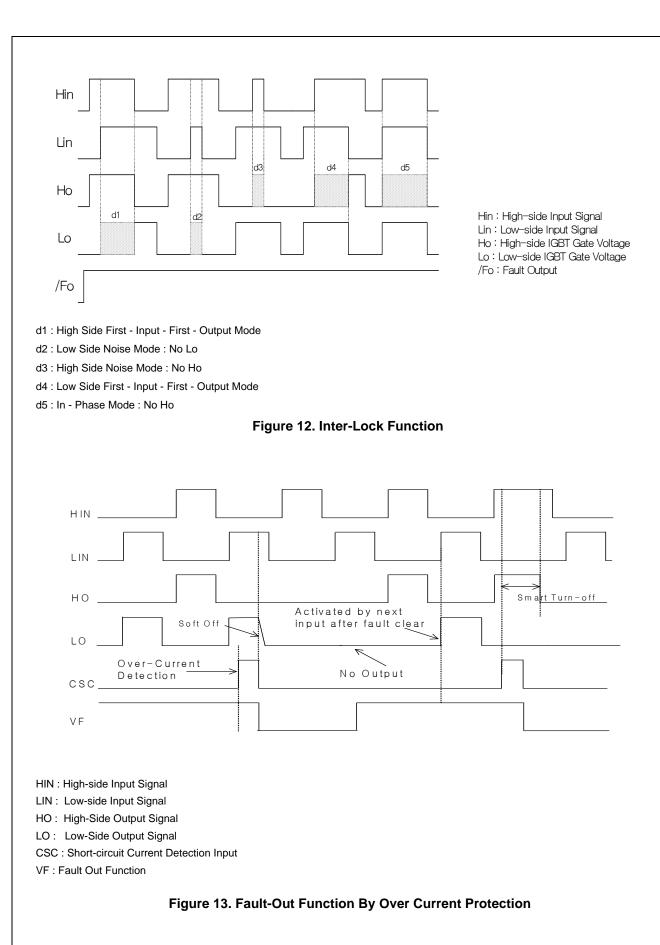


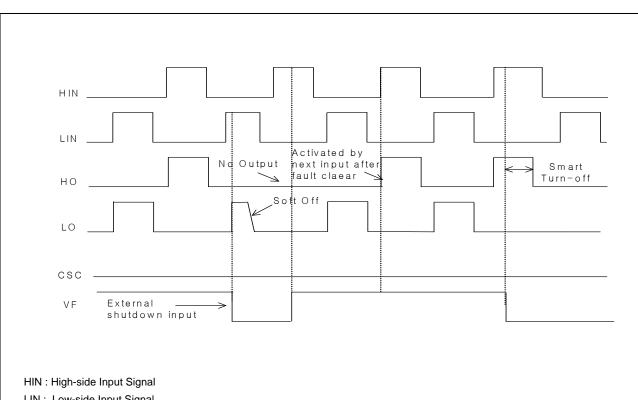
Note:

12. Do not make over torque when mounting screws. Much mounting torque may cause package cracks, as well as bolts and Al heat-sink destruction.

13. Avoid one side tightening stress. Figure 10 shows the recommended torque order for mounting screws. Uneven mounting can cause the ceramic substrate of the Motion SPM 55 product to be damaged. The Pre-screwing torque is set to 20 ~ 30 % of maximum torque rating.







LIN : Low-side Input Signal

HO: High-Side Output Signal

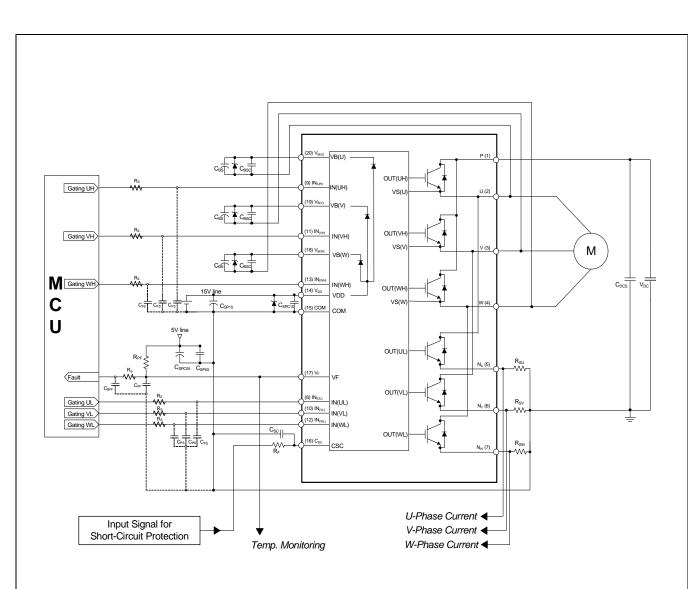
LO: Low-Side Output Signal

CSC : Over Current Detection Input

VF : Shutdown Input Function

Figure 14. Shutdown Input Function By External Command

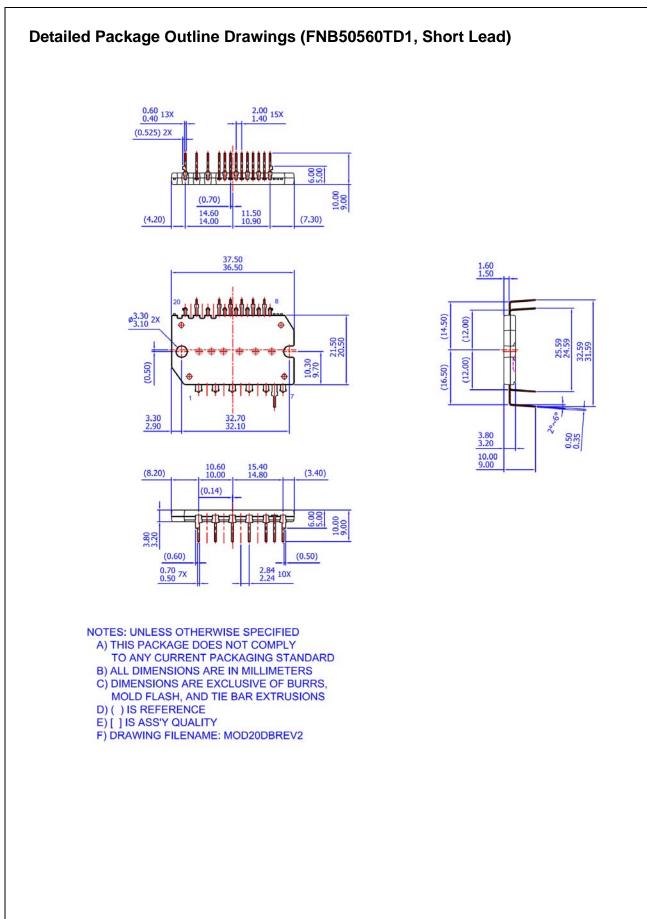
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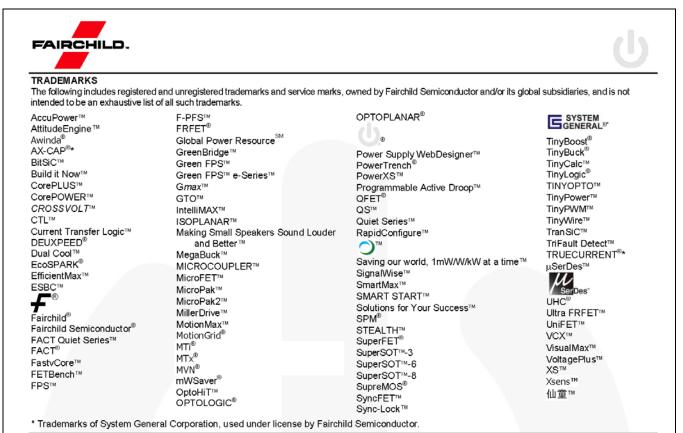


Note:

- 1) To avoid malfunction, the wiring of each input should be as short as possible. (less than 2 ~ 3 cm)
- 2) By virtue of integrating an application specific type of HVIC inside the SPM[®] 55 product, direct coupling to MCU terminals without any opto-coupler or transformer isolation is possible.
- 3) V_F is open-drain type. This signal line should be pulled up to the positive side of the MCU or control power supply with a resistor that makes I_{FO} up to 5 mA. Please refer to Figure 15.
- 4) C_{SP15} of around seven times larger than bootstrap capacitor C_{BS} is recommended.
- 5) Input signal is active-HIGH type. There is a 10 kΩ resistor inside the IC to pull down each input signal line to GND. RC coupling circuits is recommanded for the prevention of input signal oscillation. R_SC_{PS} time constant should be selected in the range 50 ~ 150 ns. (Recommended R_S = 100 Ω, C_{PS} = 1 nF)
- 6) To prevent errors of the protection function, the wiring around R_F and C_{SC} should be as short as possible.
- 7) In the short-circuit protection circuit, please select the $R_F C_{SC}$ time constant in the range 1.5 ~ 2 μ s.
- 8) The connection between control GND line and power GND line which includes the N_U, N_V, N_W must be connected to only one point. Please do not connect the control GND to the power GND by the broad pattern. Also, the wiring distance between control GND and power GND should be as short as possible.
- 9) Each capacitor should be mounted as close to the pins of the Motion SPM 55 product as possible.
- 10) To prevent surge destruction, the wiring between the smoothing capacitor and the P and GND pins should be as short as possible. The use of a high frequency non-inductive capacitor of around 0.1 ~ 0.22 μF between the P and GND pins is recommended.
- 11) Relays are used at almost every systems of electrical equipments of home appliances. In these cases, there should be sufficient distance between the CPU and the relays.
- 12) The zener diode or transient voltage suppressor should be adopted for the protection of ICs from the surge destruction between each pair of control supply terminals. (Recommanded zener diode is 22 V / 1 W, which has the lower zener impedance characteristic than about 15 Ω)
- 13) Please choose the electrolytic capacitor with good temperature characteristic in C_{BS} . Also, choose 0.1 ~ 0.2 μ F R-category ceramic capacitors with good temperature and frequency characteristics in C_{BSC} .
- 14) For the detailed information, please refer to the application notes.

Figur15. Typical Application Circuit





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